# APPENDIX C CALIBRATION DOCUMENTS

1. **E-Field Probe Model ET3DV6 S/N 1380**
2. **Antenna Dipole Model D2450V2 S/N 724**

**Calibration Laboratory of**
Schmid & Partner
Engineering AG
**Zeughausstrasse 43, 8004 Zurich, Switzerland**

S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
**The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates**

**Accreditation No.: SCS 108**

Client **EMC Technologies** Certificate No: **ET3-1380_Dec08**

# CALIBRATION CERTIFICATE

| | |
|---|---|
| Object | ET3DV6 - SN:1380 |
| Calibration procedure(s) | QA CAL-01.v6, QA CAL-12.v5 and QA CAL-23.v3<br>Calibration procedure for dosimetric E-field probes |
| Calibration date: | December 18, 2008 |
| Condition of the calibrated item | In Tolerance |

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

| Primary Standards | ID # | Cal Date (Certificate No.) | Scheduled Calibration |
|---|---|---|---|
| Power meter E4419B | GB41293874 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Power sensor E4412A | MY41495277 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Power sensor E4412A | MY41498087 | 1-Apr-08 (No. 217-00788) | Apr-09 |
| Reference 3 dB Attenuator | SN: S5054 (3c) | 1-Jul-08 (No. 217-00865) | Jul-09 |
| Reference 20 dB Attenuator | SN: S5086 (20b) | 31-Mar-08 (No. 217-00787) | Apr-09 |
| Reference 30 dB Attenuator | SN: S5129 (30b) | 1-Jul-08 (No. 217-00866) | Jul-09 |
| Reference Probe ES3DV2 | SN: 3013 | 2-Jan-08 (No. ES3-3013_Jan08) | Jan-09 |
| DAE4 | SN: 660 | 9-Sep-08 (No. DAE4-660_Sep08) | Sep-09 |

| Secondary Standards | ID # | Check Date (in house) | Scheduled Check |
|---|---|---|---|
| RF generator HP 8648C | US3642U01700 | 4-Aug-99 (in house check Oct-07) | In house check: Oct-09 |
| Network Analyzer HP 8753E | US37390585 | 18-Oct-01 (in house check Oct-08) | In house check: Oct-09 |

| | Name | Function | Signature |
|---|---|---|---|
| Calibrated by: | Katja Pokovic | Technical Manager | |
| Approved by: | Niels Kuster | Quality Manager | |

Issued: December 18, 2008

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**Glossary:**

| | |
|---|---|
| TSL | tissue simulating liquid |
| NORMx,y,z | sensitivity in free space |
| ConvF | sensitivity in TSL / NORMx,y,z |
| DCP | diode compression point |
| Polarization φ | φ rotation around probe axis |
| Polarization ϑ | ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., ϑ = 0 is normal to probe axis |

**Calibration is Performed According to the Following Standards:**

a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

**Methods Applied and Interpretation of Parameters:**

- *NORMx,y,z:* Assessed for E-field polarization ϑ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the $E^2$-field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)x,y,z = NORMx,y,z * frequency_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCPx,y,z:* DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- *ConvF and Boundary Effect Parameters:* Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORMx,y,z * ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

# Probe ET3DV6

# SN:1380

| | |
|---|---|
| Manufactured: | August 16, 1999 |
| Last calibrated: | December 18, 2007 |
| Repaired: | December 12, 2008 |
| Recalibrated: | December 18, 2008 |

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

**ET3DV6 SN:1380** **December 18, 2008**

# DASY - Parameters of Probe: ET3DV6 SN:1380

## Sensitivity in Free Space[A] Diode Compression[B]

| | | | | |
|---|---|---|---|---|
| NormX | **1.63** ± 10.1% | $\mu V/(V/m)^2$ | DCP X | **88** mV |
| NormY | **1.58** ± 10.1% | $\mu V/(V/m)^2$ | DCP Y | **88** mV |
| NormZ | **1.69** ± 10.1% | $\mu V/(V/m)^2$ | DCP Z | **89** mV |

## Sensitivity in Tissue Simulating Liquid (Conversion Factors)

**Please see Page 8.**

## Boundary Effect

**TSL** **900 MHz** **Typical SAR gradient: 5 % per mm**

| Sensor Center to Phantom Surface Distance | | **3.7 mm** | **4.7 mm** |
|---|---|---|---|
| $SAR_{be}$ [%] | Without Correction Algorithm | 10.4 | 6.3 |
| $SAR_{be}$ [%] | With Correction Algorithm | 0.9 | 0.5 |

**TSL** **1810 MHz** **Typical SAR gradient: 10 % per mm**

| Sensor Center to Phantom Surface Distance | | **3.7 mm** | **4.7 mm** |
|---|---|---|---|
| $SAR_{be}$ [%] | Without Correction Algorithm | 10.9 | 6.3 |
| $SAR_{be}$ [%] | With Correction Algorithm | 0.9 | 0.6 |

## Sensor Offset

| | |
|---|---|
| Probe Tip to Sensor Center | **2.7** mm |

**The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.**

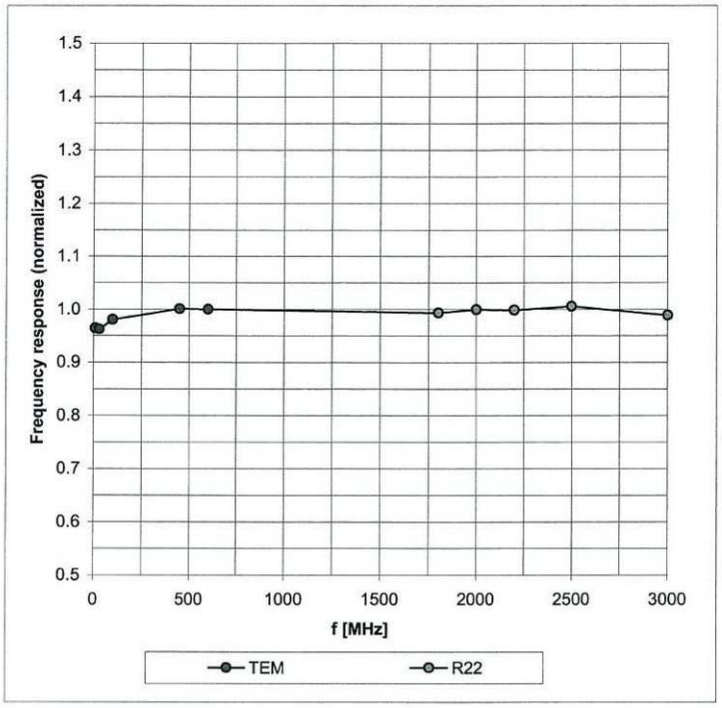
[A] The uncertainties of NormX,Y,Z do not affect the $E^2$-field uncertainty inside TSL (see Page 8).

[B] Numerical linearization parameter: uncertainty not required.

**ET3DV6 SN:1380** **December 18, 2008**

## Frequency Response of E-Field

**(TEM-Cell:ifi110 EXX, Waveguide: R22)**




**Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)**

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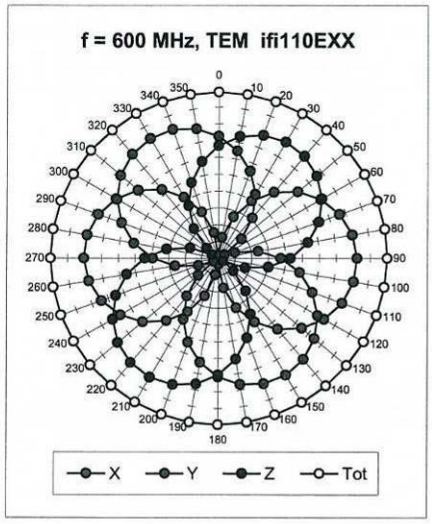
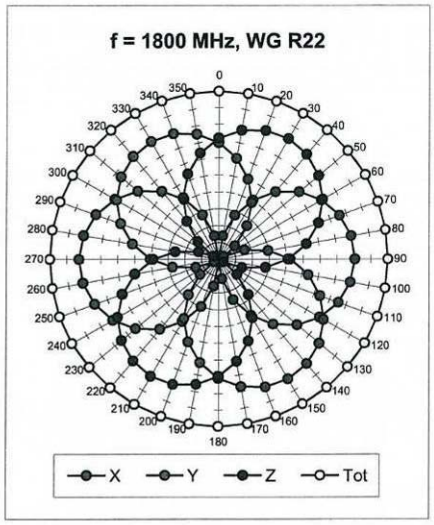
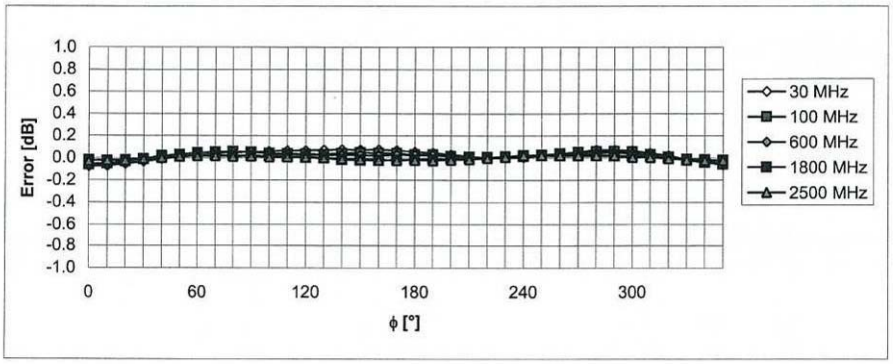
## Receiving Pattern ($\phi$), $\vartheta$ = 0°




**Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)**

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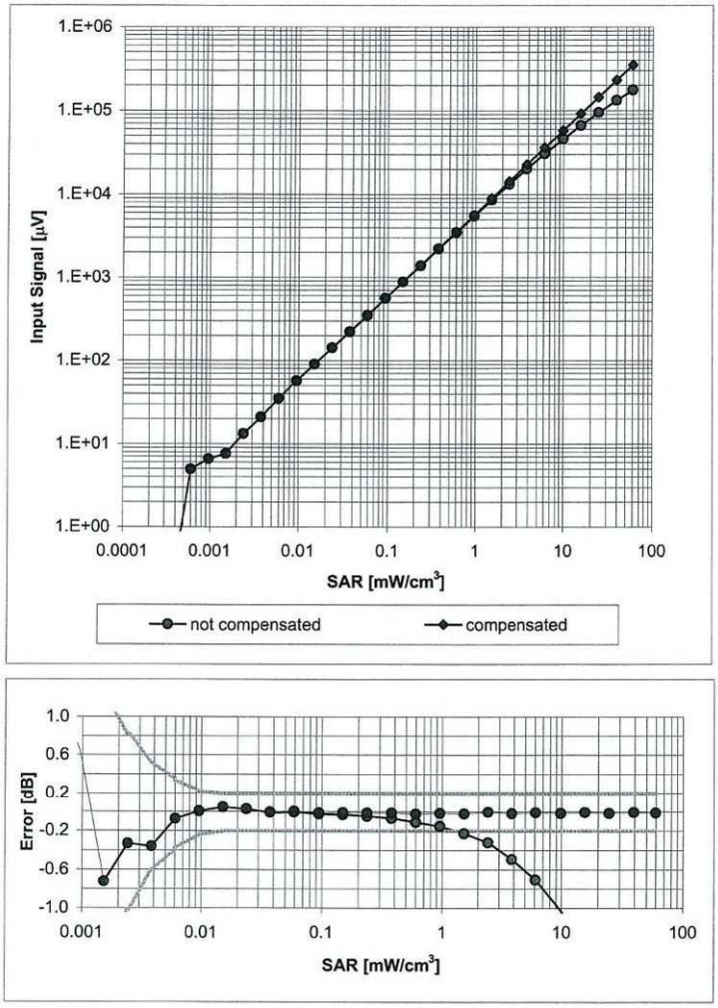
## Dynamic Range f($SAR_{head}$)

**(Waveguide R22, f = 1800 MHz)**







**Uncertainty of Linearity Assessment: ± 0.6% (k=2)**

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